

**Search Notes**

Application/Control No.

10/790,880

Examiner

Denise Tran

Applicant(s)/Patent under  
Reexamination

AKIYAMA ET AL.

Art Unit

2185

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search (USPAT, USPGPUB,USOCR,EPOAB,JPOAB,D ERWENT, IBM-TDB)	7/31/2007	DT
711/5,118,170,128-129,104,144; 365/230.03,185.11 (text search only search history)	7/31/2007	DT
711/103,105, 167; 365/189.01 (text search only search history)	7/31/2007	DT
inventor name search	7/31/2007	DT